SLOS217E-JULY 1998-REVISED MARCH 2005





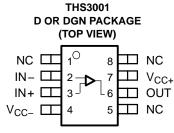
420-MHz HIGH-SPEED CURRENT-FEEDBACK AMPLIFIER

FEATURES

- High Speed
 - 420 MHz Bandwidth (G = 1, -3 dB)
 - 6500 V/µs Slew Rate
 - 40-ns Settling Time (0.1%)
- High Output Drive, I_O = 100 mA
- Excellent Video Performance
 - 115 MHz Bandwidth (0.1 dB, G = 2)
 - 0.01% Differential Gain
 - 0.02° Differential Phase
- Low 3-mV (max) Input Offset Voltage
- Very Low Distortion
 - THD = -96 dBc at f = 1 MHz
 - THD = -80 dBc at f = 10 MHz
- Wide Range of Power Supplies
 - V_{CC} = ± 4.5 V to ± 16 V
- Evaluation Module Available

APPLICATIONS

- Communication
- Imaging
- High-Quality Video



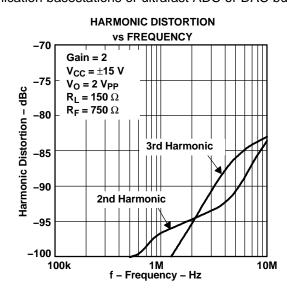
NC - No internal connection

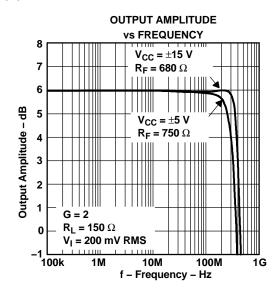
RELATED DEVICES

| THS41011/2 | 290-MHz VFB High-Speed Amplifier |
|------------|----------------------------------|
| THS6012 | 500-mA CFB Hlgh-Speed Amplifier |
| THS6022 | 250-mA CFB High-Speed Amplifier |

DESCRIPTION

The THS3001 is a high-speed current-feedback operational amplifier, ideal for communication, imaging, and high-quality video applications. This device offers a very fast 6500-V/µs slew rate, a 420-MHz bandwidth, and 40-ns settling time for large-signal applications requiring excellent transient response. In addition, the THS3001 operates with a very low distortion of –96 dBc, making it well suited for applications such as wireless communication basestations or ultrafast ADC or DAC buffers.







These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.



AVAILABLE OPTIONS(1)

| | | PACKAGED DEVICE | | TRANSPORT | EVALUATION |
|----------------|---------------------------|-----------------|----------------|------------------------|------------|
| T _A | SOIC (D) | MSOP (DGN) | MSOP SYMBOL | MEDIA, QUANTITY | MODULE |
| | THS3001CD | THS3001CDGN | | Rails, 75 | THS3001EVM |
| 0°C to 70°C | THS3001CDR | THS3001CDGNR | ADP | Tape and Reel, 2500 | 1 |
| 0.0 10 70.0 | THS3001HVCD | THS3001HVCDGN | | Rails, 75 | |
| | THS3001HVCDR | THS3001HVCDGNR | BNK | Tape and Reel, 2500 | |
| | THS3001ID | THS3001IDGN | | Rails, 75 | 1 |
| -40°C to 85°C | THS3001IDR | THS3001IDGNR | ADQ | Tape and Reel, 2500 | 1 |
| -40 C 10 65 C | THS3001HVID THS3001HVIDGN | Rails, 75 | | | |
| | THS3001HVIDR | THS3001HVIDGNR | BNJ | Tape and Reel, 2500 | |

⁽¹⁾ For the most current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI website at www.ti.com.

ABSOLUTE MAXIMUM RATINGS(1)

over operating free-air temperature range (unless otherwise noted)

| | | | THS3001 | THS3001HV | UNITS | | |
|------------------|--|---|------------------------------|------------------|-------|--|--|
| V _{SS} | Supply voltage, V _{CC+} to V _{CC-} | | 33 | 37 | V | | |
| VI | Input voltage | | ±V _{CC} | ±V _{CC} | V | | |
| Io | Output current | | 175 | 175 | mA | | |
| V_{ID} | Differential input voltage | | ±6 | ±6 | V | | |
| | Continuous total power dissipation | | See Dissipation Rating Table | | | | |
| TJ | Maximum junction temperature (2) | | 150 | 150 | °C | | |
| T_{J} | Maximum junction temperature, continuous | s operation, long term reliability ⁽³⁾ | 125 | 125 | °C | | |
| _ | Operating free air temperature | THS3001C, THS3001HVC | 0 to 70 | 0 to 70 | °C | | |
| T _A | Operating free-air temperature | Operating free-air temperature THS3001I, THS3001HVI | | -40 to 85 | °C | | |
| T _{stg} | Storage temperature | Storage temperature | | -65 to 125 | °C | | |
| | Lead temperature 1,6 mm (1/16 inch) from | case for 10 seconds | 300 | 300 | °C | | |

⁽¹⁾ Stresses above these ratings may cause permanent damage. Exposure to absolute maximum conditions for extended periods may degrade device reliability. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those specified is not implied.

DISSIPATION RATING TABLE

| PACKAGE | θјс | θ _{JA} (1) | POWER F | RATING ⁽²⁾ |
|---------|--------|---------------------|-----------------------|-----------------------|
| PACKAGE | (∘C/W) | (°Č/W) | $T_A \le 25^{\circ}C$ | T _A = 85°C |
| D (8) | 38.3 | 97.5 | 1.02 W | 410 mW |
| DGN (8) | 4.7 | 58.4 | 1.71 W | 685 mW |

⁽¹⁾ This data was taken using the JEDEC standard High-K test PCB.

⁽²⁾ The absolute maximum temperature under any condition is limited by the constraints of the silicon process.

⁽³⁾ The maximum junction temperature for continuous operation is limited by package constraints. Operation above this temperature may result in reduced reliability and/or lifetime of the device.

⁽²⁾ Power rating is determined with a junction temperature of 125°C. This is the point where distortion starts to substantially increase. Thermal management of the final PCB should strive to keep the junction temperature at or below 125°C for best performance and long term reliability.



RECOMMENDED OPERATING CONDITIONS

| | | | | MIN | NOM | MAX | UNIT |
|----------------|--|------------------|-------------|------|-----|-------|------|
| | Split supply THS3001C. | | ±4.5 | | ±16 | | |
| ., | V_{SS} Supply voltage, V_{CC+} and V_{CC-} | Single supply | THS3001I | 9 | | 32 | V |
| VSS | | Split supply | THS3001HVC, | ±4.5 | | ±18.5 | |
| | | Single supply | THS3001HVI | 9 | | 37 | |
| _ | Operating free air temperature | THS3001C, THS30 | 001HVC | 0 | | 70 | °C |
| 1 _A | Operating free-air temperature | THS3001I, THS300 | 01HVI | -40 | | 85 | ٠. |

ELECTRICAL CHARACTERISITCS

 $\rm T_A$ = 25°C, $\rm R_L$ = 150 Ω , $\rm R_F$ = 1 $\rm k\Omega$ (unless otherwise noted)

| | PARAMETER | | TEST CON | DITIONS ⁽¹⁾ | MIN | TYP | MAX | UNIT | |
|-------------------------------------|-------------------------------|--|--|-----------------------------|-------|-------|-----------|-------|--|
| | | | Split supply | THS3001C THS3001I | ±4.5 | | ±16.5 | | |
| ., | | | | THS3001HVx | ±4.5 | | ±18.5 | 1 | |
| V _{CC} | Power supply operat | Power supply operating range | | THS3001C THS3001I | 9 | | 33 | V | |
| | | | Single supply | THS3001HVx | 9 | | 37 | | |
| | | | | T _A = 25°C | | 5.5 | 7.5 | | |
| | | | $V_{CC} = \pm 5 \text{ V}$ | T _A = full range | | | 8.5 | | |
| | | | ., ., ., | T _A = 25°C | | 6.6 | 9 | | |
| I _{CC} Quiescent current | | $V_{CC} = \pm 15 \text{ V}$ | T _A = full range | | | 10 | mA | | |
| | | | $V_{CC} = \pm 18.5 \text{ V}.$ | T _A = 25°C | | 6.9 | 9.5 | | |
| | | | $V_{CC} = \pm 18.5 \text{ V},$ THS3001HV | T _A = full range | | | 10.5 | | |
| | | | | $R_L = 150 \Omega$ | ±2.9 | ±3.2 | | | |
| . , | Outrot walks as suite | | $V_{CC} = \pm 5 \text{ V}$ | $R_L = 1 k\Omega$ | ±3 | ±3.3 | | | |
| V _O Output voltage swing | it voltage swing | V 145.V | $R_L = 150 \Omega$ | ±12.1 | ±12.8 | | V | | |
| | | | $V_{CC} = \pm 15 \text{ V}$ | $R_L = 1 k\Omega$ | ±12.8 | ±13.1 | | | |
| | | $V_{CC} = \pm 5 \text{ V},$ | $R_L = 20 \Omega$ | | 100 | | | | |
| I _O | Output current ⁽²⁾ | | $V_{CC} = \pm 15 \text{ V},$ | $R_L = 75 \Omega$ | 85 | 120 | | mA | |
| | | | | T _A = 25°C | | 1 | 3 | | |
| V_{IO} | Input offset voltage | | $V_{CC} = \pm 5 \text{ V or } \pm 15 \text{ V}$ | T _A = full range | | | 4 | mV | |
| | Input offset voltage of | Irift | V _{CC} = ±5 V or ±15 V | | | 5 | | μV/°C | |
| | | D ::: (IN) | | T _A = 25°C | | 2 | 10 | | |
| | | Positive (IN+) | | T _A = full range | | | 15 | | |
| I _{IB} | Input bias current | | $V_{CC} = \pm 5 \text{ V or } \pm 15 \text{ V}$ | T _A = 25°C | | 1 | 10 | 10 µA | |
| | | Negative (IN-) | | T _A = full range | | | 15 | | |
| ., | | | $V_{CC} = \pm 5 \text{ V}$ | | ±3 | ±3.2 | | ., | |
| V_{ICR} | Common-mode inpu | t voltage range | V _{CC} = ±15 V | | ±12.9 | ±13.2 | | V | |
| | 0 1 | | $V_{CC} = \pm 5 \text{ V}, V_{O} = \pm 2.5$ | $V, R_L = 1 k\Omega$ | - U. | 1.3 | | | |
| Open loop transresistance | | $V_{CC} = \pm 15 \text{ V}, V_{O} = \pm 7.5$ | 5 V, $R_L = 1 \text{ k}\Omega$ | | 2.4 | | $M\Omega$ | | |
| 0.100 | | | $V_{CC} = \pm 5 \text{ V}, V_{CM} = \pm 2.5 \text{ V}$ | | 62 | 70 | | | |
| CMRR Common-mode rejection ratio | | $V_{CC} = \pm 15 \text{ V}, V_{CM} = \pm 1$ | | 65 | 73 | | dB | | |
| | | | | T _A = 25°C | 65 | 76 | | dB | |
| DODE | Dames I I I | | $V_{CC} = \pm 5 \text{ V}$ | T _A = full range | 63 | | | | |
| PSRR | Power supply rejection | Power supply rejection ratio | | T _A = 25°C | 69 | 76 | | | |
| | | | $V_{CC} = \pm 15 \text{ V}$ | T _A = full range | 67 | | | dB | |

⁽¹⁾ Full range = 0° C to 70° C for the THS3001C and -40° C to 85° C for the THS3001I.

⁽²⁾ Observe power dissipation ratings to keep the junction temperature below absolute maximum when the output is heavily loaded or shorted. See absolute maximum ratings section.



ELECTRICAL CHARACTERISITCS (continued)

 $\rm T_A$ = 25°C, $\rm R_L$ = 150 Ω , $\rm R_F$ = 1 $\rm k\Omega$ (unless otherwise noted)

| PARAMETER | | | TEST CONDITIONS(1) | MIN | TYP | MAX | UNIT | |
|------------------------|-------------------------|----------------|--|-----|-----|-----|--------------------|--|
| D. January and January | | Positive (IN+) | | | 1.5 | | Ω M | |
| R _I | Input resistance | Negative (IN-) | | | 15 | | Ω | |
| CI | Differential input capa | acitance | | | 7.5 | | рF | |
| R _O | Output resistance | | Open loop at 5 MHz | | 10 | | Ω | |
| V _n | Input voltage noise | | $V_{CC} = \pm 5 \text{ V or } \pm 15 \text{ V, } f = 10 \text{ kHz, } G = 2$ | | 1.6 | | nV/√ Hz | |
| | Positive (IN+) | | V _{CC} = ±5 V or ±15 V, f = 10 kHz, G = 2 | | 13 | | pA/√ Hz | |
| Input current noise | | Negative (IN-) | $V_{CC} = \pm 5 \text{ V OI } \pm 15 \text{ V, I} = 10 \text{ kHz, G} = 2$ | | 16 | | pA/\nz | |

OPERATING CHARACTERISTICS

 $\rm T_A$ = 25°C, $\rm R_L$ = 150 Ω , $\rm R_F$ = 1 $\rm k\Omega$ (unless otherwise noted)

| PARAMETER | | TEST CONDITIO | NS | MIN TYP | MAX | UNIT |
|----------------|-------------------------------------|---|------------------------------------|---------|-----|--------|
| | | V _{CC} = ±5 V, | G = -5 | 1700 | | |
| CD | Slew rate ⁽¹⁾ | $V_{O(PP)} = 4 \text{ V}$ | G = 5 | 1300 | | |
| SR | Siew rate (1) | $V_{CC} = \pm 15 \text{ V},$ | G = -5 | 6500 | | V/µs |
| | | $V_{O(PP)} = 20 \text{ V}$ | G = 5 | 6300 | | ì |
| | Settling time to 0.1% | V _{CC} = ±15 V, 0 V to 10 V Step | Gain = -1, | 40 | | |
| t _s | Settling time to 0.1% | V _{CC} = ±5 V, 0 V to 2 V Step, | Gain = -1, | 25 | | ns |
| THD | Total harmonic distortion | $V_{CC} = \pm 15 \text{ V},$ $f_{c} = 10 \text{ MHz},$ | V _{O(PP)} = 2 V, G = 2 | -80 | | dBc |
| | Differential gain array | G = 2, 40 IRE modulation, | $V_{CC} = \pm 5 \text{ V}$ | 0.015% | | |
| | Differential gain error | ±100 IRE Ramp, NTSC and PAL | V _{CC} = ±15 V | 0.01% | | ı |
| | Differential phase arror | G = 2, 40 IRE modulation, | $V_{CC} = \pm 5 \text{ V}$ | 0.01° | | |
| | Differential phase error | ±100 IRE Ramp, NTSC and PAL | $V_{CC} = \pm 15 \text{ V}$ | 0.02° | | ı |
| | | $G = 1$, $R_F = 1 k\Omega$ | $V_{CC} = \pm 5 \text{ V}$ | 330 | | MHz |
| | | $G = 1$, $K_F = 1$ K22 | V _{CC} = ±15 V | 420 | | MHz |
| | Small signal bandwidth (-3 dB) | $G = 2$, $R_F = 750 Ω$, | $V_{CC} = \pm 5 \text{ V}$ | 300 | | |
| BW | | $G = 2$, $R_F = 680 Ω$, | $V_{CC} = \pm 15 \text{ V}$ | 385 | | MHz |
| | | $G = 5$, $R_F = 560 Ω$, | V _{CC} = ±15 V | 350 | | ī |
| | Dandwidth for 0.1 dD flatages | $G = 2$, $R_F = 750 Ω$, | V _{CC} = ±5 V | 85 | | MHz |
| | Bandwidth for 0.1 dB flatness | $G = 2$, $R_F = 680 Ω$, | V _{CC} = ±15 V | 115 | | IVIIIZ |
| | | $V_{CC} = \pm 5 \text{ V}, V_{O(PP)} = 4 \text{ V},$ | G = -5 | 65 | | |
| | Full power handwidth (2) | $R_L = 500\Omega$ | G = 5 | 62 | | |
| | Full power bandwidth ⁽²⁾ | $V_{CC} = \pm 15 \text{ V}, V_{O(PP)} = 20 \text{ V},$ | G = -5 | 32 | | MHz |
| | | $R_L = 500\Omega$ | G = 5 | 31 | | i |

Slew rate is measured from an output level range of 25% to 75%. Full power bandwidth is defined as the frequency at which the output has 3% THD.



PARAMETER MEASUREMENT INFORMATION

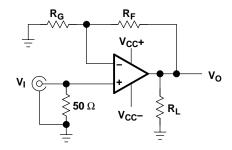


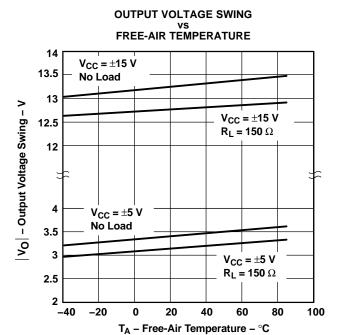
Figure 1. Test Circuit, Gain = $1 + (R_F/R_G)$

TYPICAL CHARACTERISTICS

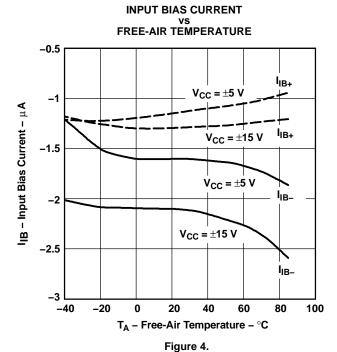
Table of Graphs

| | | | FIGURE |
|-----------------|---|--------------------------------------|---------|
| V _O | Output voltage swing | vs Free-air temperature | 2 |
| I _{CC} | Current supply | vs Free-air temperature | 3 |
| I _{IB} | Input bias current | vs Free-air temperature | 4 |
| V _{IO} | Input offset voltage | vs Free-air temperature | 5 |
| | | vs Common-mode input voltage | 6 |
| CMRR | Common-mode rejection ratio | vs Common-mode input voltage | 7 |
| | | vs Frequency | 8 |
| | Transresistance | vs Free-air temperature | 9 |
| | Closed-loop output impedance | vs Frequency | 10 |
| V _n | Voltage noise | vs Frequency | 11 |
| In | Current noise | vs Frequency | 11 |
| DCDD | Device events releasing notice | vs Frequency | 12 |
| PSRR | Power supply rejection ratio | vs Free-air temperature | 13 |
| | Slew rate | vs Supply voltage | 14 |
| SR | Siew rate | vs Output step peak-to-peak | 15, 16 |
| | Normalized slew rate | vs Gain | 17 |
| | Harmonic distortion | vs Peak-to-peak output voltage swing | 18, 19 |
| | Harmonic distortion | vs Frequency | 20, 21 |
| | Differential gain | vs Loading | 22, 23 |
| | Differential phase | vs Loading | 24, 25 |
| | Output amplitude | vs Frequency | 26-30 |
| | Normalized output response | vs Frequency | 31-34 |
| | Small and large signal frequency response | | 35, 36 |
| | Small signal pulse response | | 37, 38 |
| | Large signal pulse response | | 39 - 46 |









CURRENT SUPPLY vs FREE-AIR TEMPERATURE

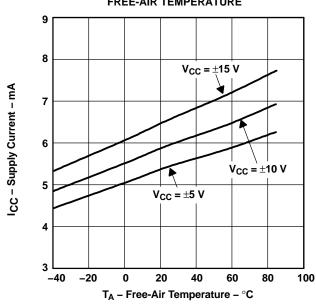


Figure 3.

INPUT OFFSET VOLTAGE vs FREE-AIR TEMPERATURE

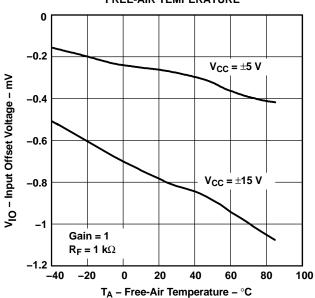
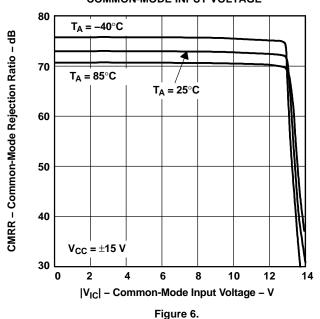


Figure 5.



COMMON-MODE REJECTION RATIO vs COMMON-MODE INPUT VOLTAGE



COMMON-MODE REJECTION RATIO vs FREQUENCY

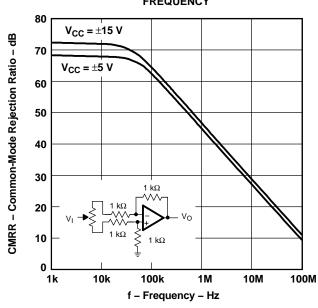


Figure 8.

COMMON-MODE REJECTION RATIO vs COMMON-MODE INPUT VOLTAGE

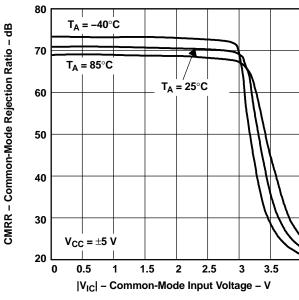
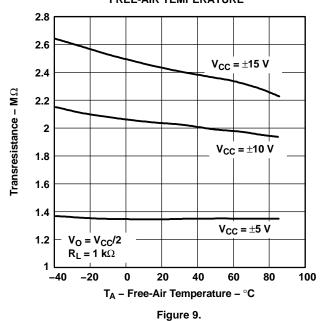


Figure 7.

TRANSRESISTANCE VS FREE-AIR TEMPERATURE





CLOSED-LOOP OUTPUT IMPEDANCE vs FREQUENCY

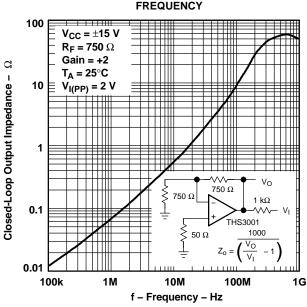


Figure 10.

POWER SUPPLY REJECTION RATIO vs FREQUENCY

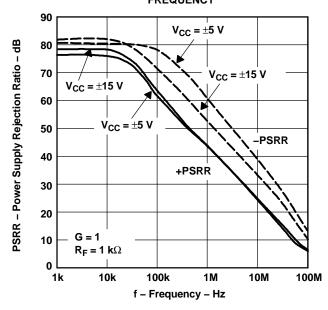


Figure 12.

VOLTAGE NOISE AND CURRENT NOISE VS FREQUENCY

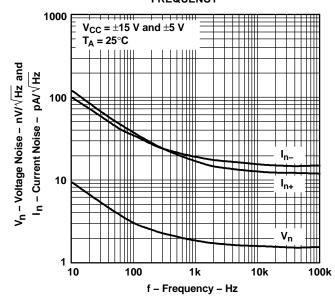


Figure 11.

POWER SUPPLY REJECTION RATIO vs FREE-AIR TEMPERATURE

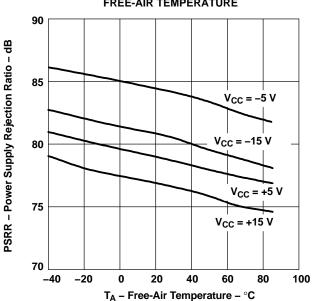
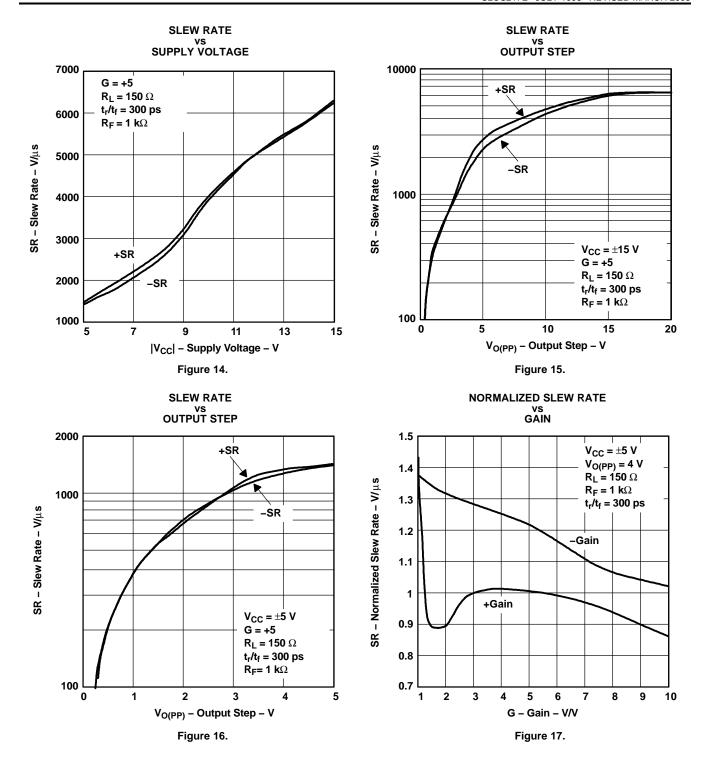


Figure 13.







HARMONIC DISTORTION VS PEAK-TO-PEAK OUTPUT VOLTAGE SWING

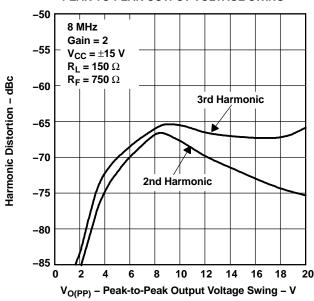


Figure 18.

HARMONIC DISTORTION vs FREQUENCY

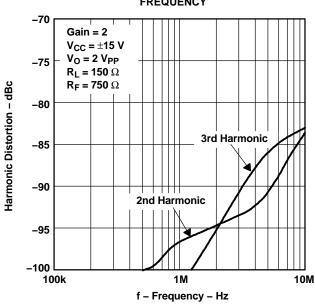


Figure 20.

HARMONIC DISTORTION vs PEAK-TO-PEAK OUTPUT VOLTAGE SWING

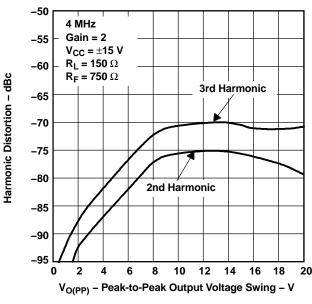


Figure 19.

HARMONIC DISTORTION vs FREQUENCY

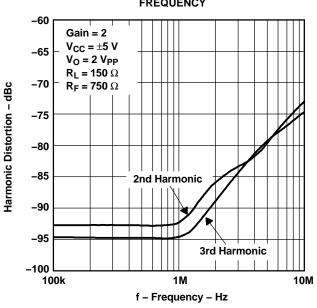
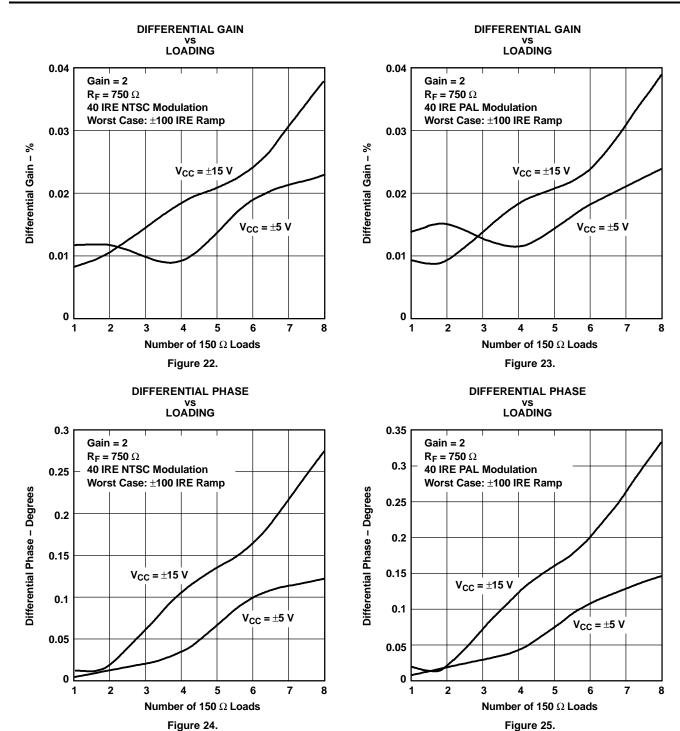


Figure 21.







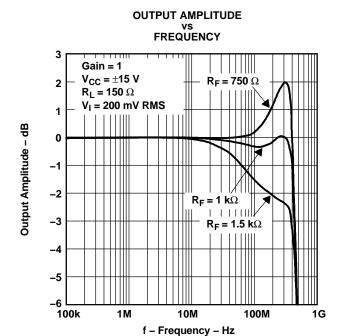
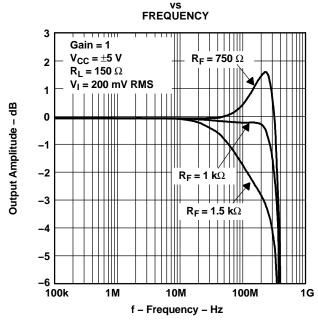


Figure 26.

OUTPUT AMPLITUDE



OUTPUT AMPLITUDE

Figure 27.

OUTPUT AMPLITUDE

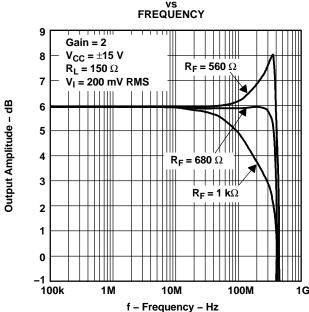


Figure 28.



Output Amplitude - dB

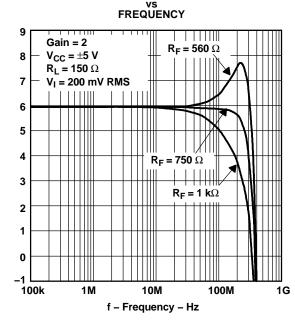
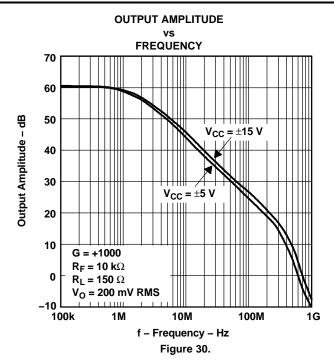
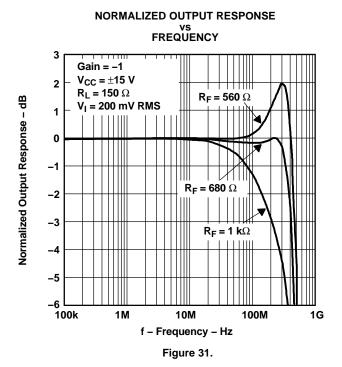
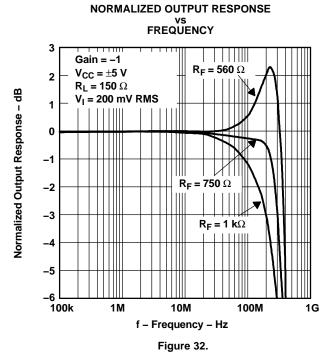


Figure 29.











NORMALIZED OUTPUT RESPONSE vs FREQUENCY

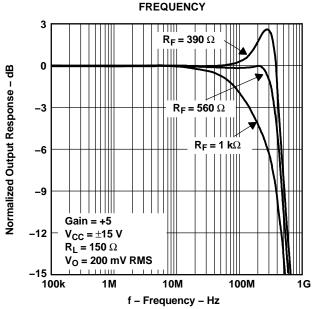


Figure 33.

NORMALIZED OUTPUT RESPONSE vs FREQUENCY

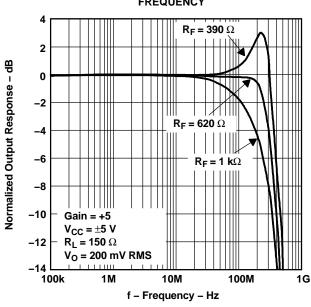


Figure 34.

SMALL AND LARGE SIGNAL FREQUENCY RESPONSE

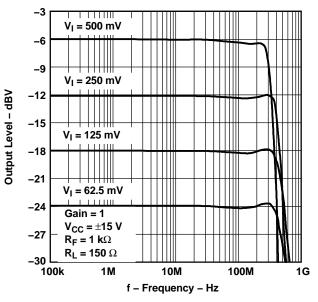


Figure 35.

SMALL AND LARGE SIGNAL FREQUENCY RESPONSE

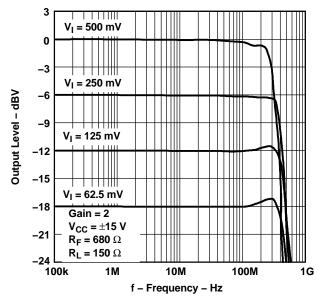
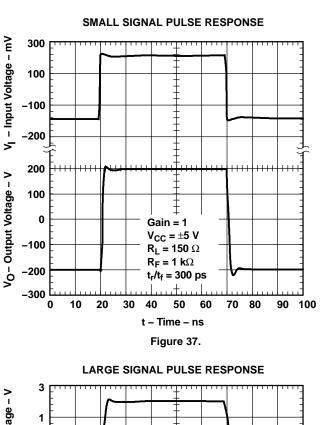
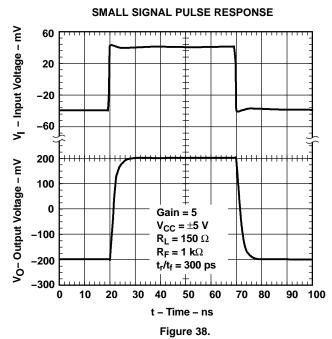
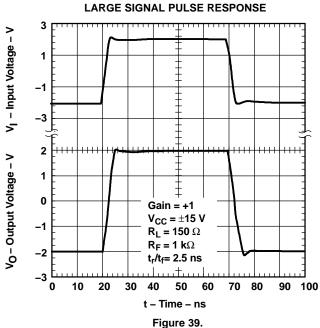


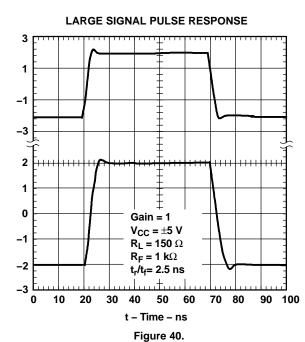
Figure 36.







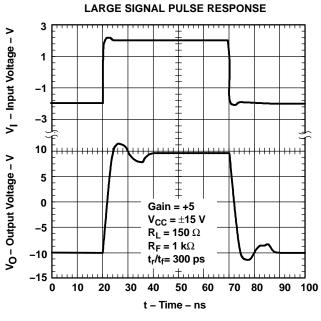


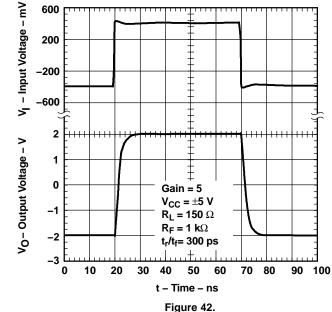


V_I - Input Voltage - V

Vo - Output Voltage - V

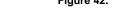


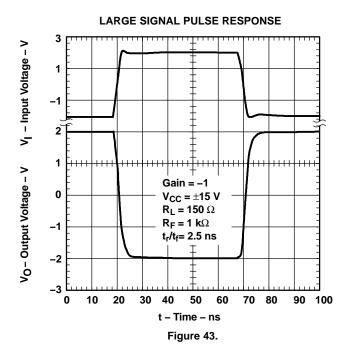


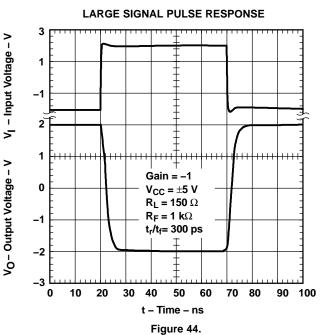


LARGE SIGNAL PULSE RESPONSE

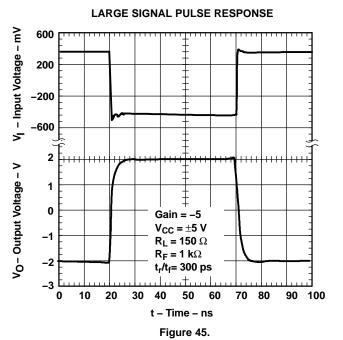


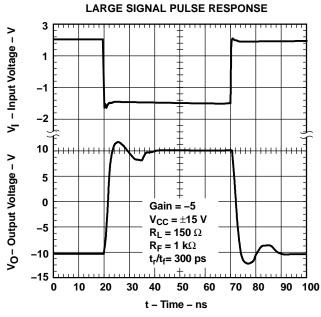












APPLICATION INFORMATION

THEORY OF OPERATION

The THS3001 is a high-speed, operational amplifier configured in a current-feedback architecture. The device is built using a 30-V, dielectrically isolated, complementary bipolar process with NPN and PNP transistors possessing f_T s of several GHz. This configuration implements an exceptionally high-performance amplifier that has a wide bandwidth, high slew rate, fast settling time, and low distortion. A simplified schematic is shown in Figure 47.

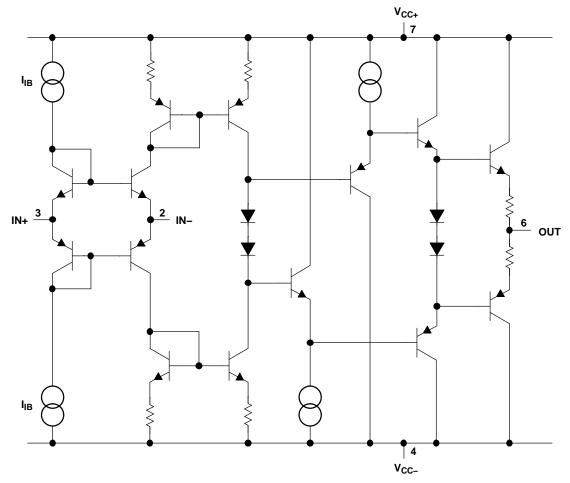


Figure 47. Simplified Schematic

RECOMMENDED FEEDBACK AND GAIN RESISTOR VALUES

The THS3001 is fabricated using Texas Instruments 30-V complementary bipolar process, HVBiCOM. This process provides the excellent isolation and extremely high slew rates that result in superior distortion characteristics.

As with all current-feedback amplifiers, the bandwidth of the THS3001 is an inversely proportional function of the value of the feedback resistor (see Figures 26 to 34). The recommended resistors for the optimum frequency response are shown in Table 1. These should be used as a starting point and once optimum values are found, 1% tolerance resistors should be used to maintain frequency response characteristics. For most applications, a feedback resistor value of 1 k Ω is recommended - a good compromise between bandwidth and phase margin that yields a stable amplifier.



APPLICATION INFORMATION (continued)

Consistent with current-feedback amplifiers, increasing the gain is best accomplished by changing the gain resistor, not the feedback resistor. This is because the bandwidth of the amplifier is dominated by the feedback resistor value and internal dominant-pole capacitor. The ability to control the amplifier gain independent of the bandwidth constitutes a major advantage of current-feedback amplifiers over conventional voltage-feedback amplifiers. Therefore, once a frequency response is found suitable to a particular application, adjust the value of the gain resistor to increase or decrease the overall amplifier gain.

Finally, it is important to realize the effects of the feedback resistance on distortion. Increasing the resistance decreases the loop gain and increases the distortion. It is also important to know that decreasing load impedance increases total harmonic distortion (THD). Typically, the third-order harmonic distortion increases more than the second-order harmonic distortion.

Table 1. Recommended Resistor Values for Optimum Frequency Response

| GAIN | R_F for $V_{CC} = \pm 15 \text{ V}$ | R_F for $V_{CC} = \pm 5 V$ |
|-------|---------------------------------------|------------------------------|
| 1 | 1 kΩ | 1 kΩ |
| 2, -1 | 680 Ω | 750 Ω |
| 2 | 620 Ω | 620 Ω |
| 5 | 560 Ω | 620 Ω |

OFFSET VOLTAGE

The output offset voltage, (V_{OO}) is the sum of the input offset voltage (V_{IO}) and both input bias currents (I_{IB}) times the corresponding gains. The following schematic and formula can be used to calculate the output offset voltage:

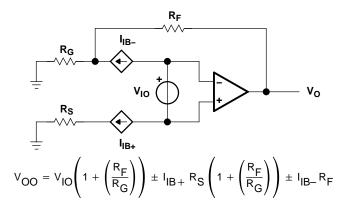


Figure 48. Output Offset Voltage Model



NOISE CALCULATIONS

Noise can cause errors on small signals. This is especially true for amplifying small signals coming over a transmission line or an antenna. The noise model for current-feedback amplifiers (CFB) is the same as for voltage feedback amplifiers (VFB). The only difference between the two is that CFB amplifiers generally specify different current-noise parameters for each input, while VFB amplifiers usually only specify one noise-current parameter. The noise model is shown in Figure 49. This model includes all of the noise sources as follows:

- $e_n = Amplifier internal voltage noise (nV/<math>\sqrt{Hz}$)
- IN+ = Nonverting current noise (pA/√Hz)
- IN- = Inverting current noise (pA/√Hz)
- e_{Rx} = Thermal voltage noise associated with each resistor (e_{Rx} = 4 kTR_x)

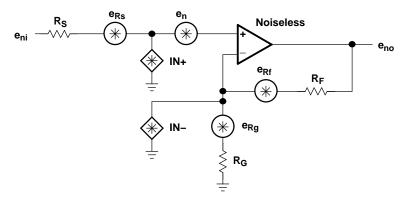


Figure 49. Noise Model

The total equivalent input noise density (eni) is calculated by using the following equation:

$$\mathbf{e}_{ni} = \sqrt{\left(\mathbf{e}_{n}\right)^{2} + \left(\mathbf{IN} + \times \mathbf{R}_{S}\right)^{2} + \left(\mathbf{IN} - \times \left(\mathbf{R}_{F} \parallel \mathbf{R}_{G}\right)\right)^{2} + 4 \, \mathbf{kTR}_{S} + 4 \, \mathbf{kT} \left(\mathbf{R}_{F} \parallel \mathbf{R}_{G}\right)}}$$

Where:

 $k = Boltzmann's constant = 1.380658 \times 10^{-23}$

T = Temperature in degrees Kelvin (273 $+^{\circ}$ C)

 $R_F \parallel R_G$ = Parallel resistance of R_F and R_G

To get the equivalent output noise of the amplifier, just multiply the equivalent input noise density (e_{ni}) by the overall amplifier gain (A_{v}) .

$$e_{no} = e_{ni} A_V = e_{ni} \left(1 + \frac{R_F}{R_G} \right)$$
 (Noninverting Case)

As the previous equations show, to keep noise at a minimum, small value resistors should be used. As the closed-loop gain is increased (by reducing $R_{\rm G}$), the input noise is reduced considerably because of the parallel resistance term. This leads to the general conclusion that the most dominant noise sources are the source resistor ($R_{\rm S}$) and the internal amplifier noise voltage ($e_{\rm n}$). Because noise is summed in a root-mean-squares method, noise sources smaller than 25% of the largest noise source can be effectively ignored. This can greatly simplify the formula and make noise calculations much easier.

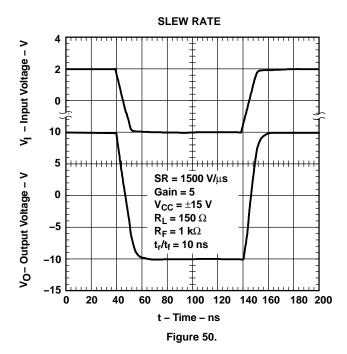


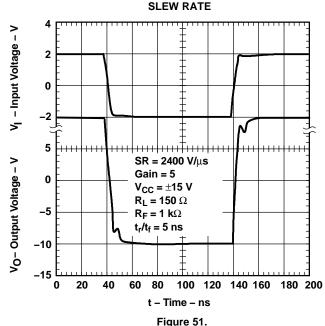
SLEW RATE

The slew rate performance of a current-feedback amplifier, like the THS3001, is affected by many different factors. Some of these factors are external to the device, such as amplifier configuration and PCB parasitics, and others are internal to the device, such as available currents and node capacitance. Understanding some of these factors should help the PCB designer arrive at a more optimum circuit with fewer problems.

Whether the THS3001 is used in an inverting amplifier configuration or a noninverting configuration can impact the output slew rate. As can be seen from the specification tables as well as some of the figures in this data sheet, slew-rate performance in the inverting configuration is faster than in the noninverting configuration. This is because in the inverting configuration the input terminals of the amplifier are at a virtual ground and do not significantly change voltage as the input changes. Consequently, the time to charge any capacitance on these input nodes is less than for the noninverting configuration, where the input nodes actually do change in voltage an amount equal to the size of the input step. In addition, any PCB parasitic capacitance on the input nodes degrades the slew rate further simply because there is more capacitance to charge. Also, if the supply voltage (V_{CC}) to the amplifier is reduced, slew rate decreases because there is less current available within the amplifier to charge the capacitance on the input nodes as well as other internal nodes.

Internally, the THS3001 has other factors that impact the slew rate. The amplifier's behavior during the slew-rate transition varies slightly depending upon the rise time of the input. This is because of the way the input stage handles faster and faster input edges. Slew rates (as measured at the amplifier output) of less than about 1500 V/µs are processed by the input stage in a linear fashion. Consequently, the output waveform smoothly transitions between initial and final voltage levels. This is shown in Figure 50. For slew rates greater than 1500 V/µs, additional slew-enhancing transistors present in the input stage begin to turn on to support these faster signals. The result is an amplifier with extremely fast slew-rate capabilities. Figure 50 and Figure 51 show waveforms for these faster slew rates. The additional aberrations present in the output waveform with these faster-slewing input signals are due to the brief saturation of the internal current mirrors. This phenomenon, which typically lasts less than 20 ns, is considered normal operation and is not detrimental to the device in any way. If for any reason this type of response is not desired, then increasing the feedback resistor or slowing down the input-signal slew rate reduces the effect.







DRIVING A CAPACITIVE LOAD

Driving capacitive loads with high-performance amplifiers is not a problem as long as certain precautions are taken. The first is to realize that the THS3001 has been internally compensated to maximize its bandwidth and slew-rate performance. When the amplifier is compensated in this manner, capacitive loading directly on the output will decrease the device's phase margin leading to high-frequency ringing or oscillations. Therefore, for capacitive loads of greater than 10 pF, it is recommended that a resistor be placed in series with the output of the amplifier, as shown in Figure 52. A minimum value of 20Ω should work well for most applications. For example, in 75- Ω transmission systems, setting the series resistor value to 75 Ω both isolates any capacitance loading and provides the proper line impedance matching at the source end.

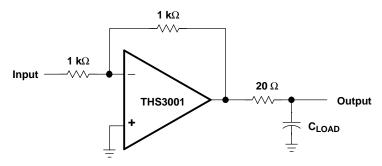


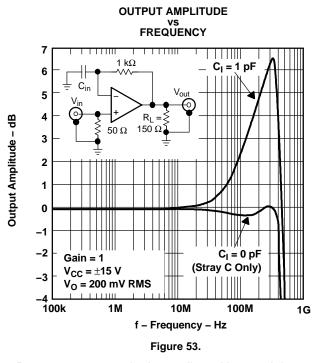
Figure 52. Driving a Capacitive Load

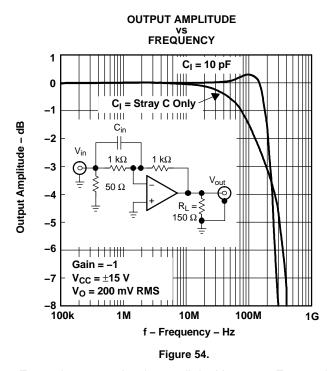


PCB DESIGN CONSIDERATIONS

Proper PCB design techniques in two areas are important to ensure proper operation of the THS3001. These areas are high-speed layout techniques and thermal-management techniques. Because the THS3001 is a high-speed part, the following guidelines are recommended.

- Ground plane It is essential that a ground plane be used on the board to provide all components with a low
 inductive ground connection. Although a ground connection directly to a terminal of the THS3001 is not
 necessarily required, it is recommended that the thermal pad of the package be tied to ground. This serves
 two functions: it provides a low inductive ground to the device substrate to minimize internal crosstalk, and it
 provides the path for heat removal.
- Input stray capacitance To minimize potential problems with amplifier oscillation, the capacitance at the inverting input of the amplifiers must be kept to a minimum. To do this, PCB trace runs to the inverting input must be as short as possible, the ground plane must be removed under any etch runs connected to the inverting input, and external components should be placed as close as possible to the inverting input. This is especially true in the noninverting configuration. An example of this can be seen in Figure 53, which shows what happens when a 1-pF capacitor is added to the inverting input terminal. The bandwidth increases at the expense of peaking. This is because some of the error current is flowing through the stray capacitor instead of the inverting node of the amplifier. Although, while the device is in the inverting mode, stray capacitance at the inverting input has a minimal effect. This is because the inverting node is at a *virtual ground* and the voltage does not fluctuate nearly as much as in the noninverting configuration. This can be seen in Figure 54, where a 10-pF capacitor adds only 0.35 dB of peaking. In general, as the gain of the system increases, the output peaking due to this capacitor decreases. While this can initially look like a faster and better system, overshoot and ringing are more likely to occur under fast transient conditions. So proper analysis of adding a capacitor to the inverting input node should be performed for stable operation.





• Proper power-supply decoupling - Use a minimum 6.8-µF tantalum capacitor in parallel with a 0.1-µF ceramic capacitor on each supply terminal. It may be possible to share the tantalum among several amplifiers depending on the application, but a 0.1-µF ceramic capacitor should always be used on the supply terminal of every amplifier. In addition, the 0.1-µF capacitor should be placed as close as possible to the supply terminal. As this distance increases, the inductance in the connecting etch makes the capacitor less effective. The designer should strive for distances of less than 0.1 inch between the device power terminal and the ceramic capacitors.



THERMAL INFORMATION

The THS3001 incorporates output-current-limiting protection. Should the output become shorted to ground, the output current is automatically limited to the value given in the data sheet. While this protects the output against excessive current, the device internal power dissipation increases due to the high current and large voltage drop across the output transistors. Continuous output shorts are not recommended and could damage the device. Additionally, connection of the amplifier output to one of the supply rails ($\pm V_{CC}$) is not recommended. Failure of the device is possible under this condition and should be avoided. But, the THS3001 does not incorporate thermal-shutdown protection. Because of this, special attention must be paid to the device's power dissipation or failure may result.

The thermal coefficient θ_{JA} is approximately 169°C/W for the SOIC 8-pin D package. For a given θ_{JA} , the maximum power dissipation, shown in Figure 55, is calculated by the following formula:

$$P_{D} = \left(\frac{T_{MAX}^{-T}A}{\theta_{JA}}\right)$$

Where:

 P_D = Maximum power dissipation of THS3001 (watts) T_{MAX} = Absolute maximum junction temperature (150°C)

 T_A = Free-ambient air temperature (°C)

 θ_{JA} = Thermal coefficient from die junction to ambient air (°C/W)

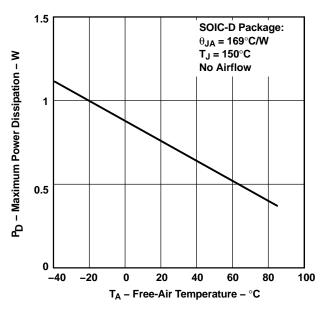


Figure 55. Maximum Power Dissipation vs Free-Air Temperature

GENERAL CONFIGURATIONS

A common error for the first-time CFB user is the creation of a unity gain buffer amplifier by shorting the output directly to the inverting input. A CFB amplifier in this configuration will oscillate and is *not* recommended. The THS3001, like all CFB amplifiers, *must* have a feedback resistor for stable operation. Additionally, placing capacitors directly from the output to the inverting input is not recommended. This is because, at high frequencies, a capacitor has a low impedance. This results in an unstable amplifier and should not be considered when using a current-feedback amplifier. Because of this, integrators and simple low-pass filters, which are easily implemented on a VFB amplifier, have to be designed slightly differently. If filtering is required, simply place an RC-filter at the noninverting terminal of the operational-amplifier (see Figure 56).



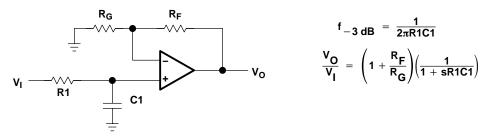


Figure 56. Single-Pole Low-Pass Filter

If a multiple-pole filter is required, the use of a Sallen-Key filter can work well with CFB amplifiers. This is because the filtering elements are not in the negative feedback loop and stability is not compromised. Because of their high slew rates and high bandwidths, CFB amplifiers can create accurate signals and help minimize distortion. An example is shown in Figure 57.

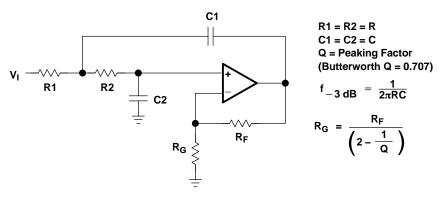


Figure 57. 2-Pole Low-Pass Sallen-Key Filter

There are two simple ways to create an integrator with a CFB amplifier. The first, shown in Figure 58, adds a resistor in series with the capacitor. This is acceptable because at high frequencies, the resistor is dominant and the feedback impedance never drops below the resistor value. The second, shown in Figure 59, uses positive feedback to create the integration. Caution is advised because oscillations can occur due to the positive feedback.

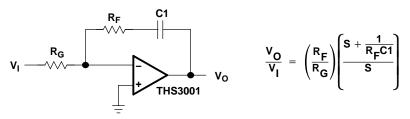


Figure 58. Inverting CFB Integrator



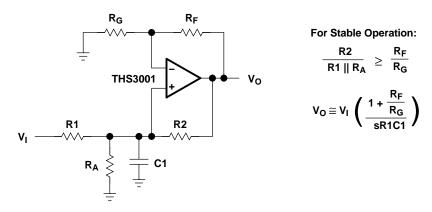


Figure 59. Noninverting CFB Integrator

The THS3001 may also be employed as a good video distribution amplifier. One characteristic of distribution amplifiers is the fact that the differential phase (DP) and the differential gain (DG) are compromised as the number of lines increases and the closed-loop gain increases (see Figures 22 to 25 for more information). Be sure to use termination resistors throughout the distribution system to minimize reflections and capacitive loading.

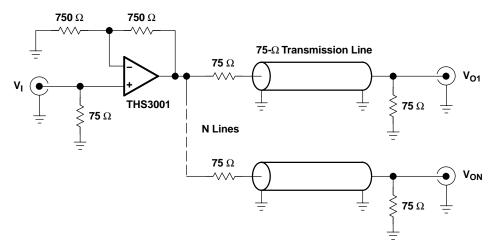


Figure 60. Video Distribution Amplifier Application



EVALUATION BOARD

An evaluation boards is available for the THS3001 (SLOP130). The board has been configured for low parasitic capacitance in order to realize the full performance of the amplifier. A schematic of the evaluation board is shown in Figure 61. The circuitry has been designed so that the amplifier may be used in either an inverting or noninverting configuration. For more detailed information, refer to the *THS3001 EVM User's Manual* (literature number SLOV021). To order the evaluation board, contact your local TI sales office or distributor.

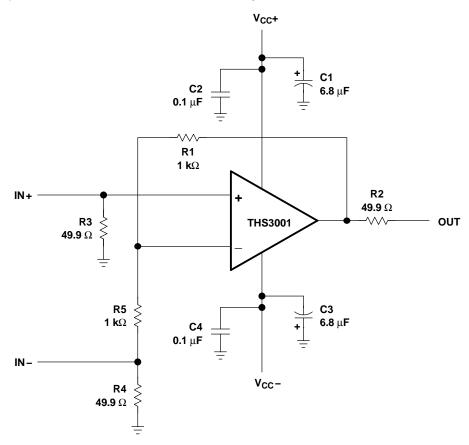


Figure 61. THS3001 Evaluation Board Schematic



PACKAGING INFORMATION

| Orderable Device | Status ⁽¹⁾ | Package Type | Package Drawing | Pins | Package Qty | e Eco Plan ⁽²⁾ | Lead/Ball Finish | MSL Peak Temp ⁽³⁾ |
|------------------|-----------------------|-----------------------|--------------------|------|----------------|----------------------------|------------------|------------------------------|
| THS3001CD | ACTIVE | SOIC | D | 8 | 75 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |
| THS3001CDG4 | ACTIVE | SOIC | D | 8 | 75 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |
| THS3001CDGN | ACTIVE | MSOP- Power PAD | DGN | 8 | 80 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |
| THS3001CDGNG4 | ACTIVE | MSOP- Power PAD | DGN | 8 | 80 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |
| THS3001CDGNR | ACTIVE | MSOP- Power PAD | DGN | 8 | 2500 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |
| THS3001CDGNRG4 | ACTIVE | MSOP- Power PAD | DGN | 8 | 2500 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |
| THS3001CDR | ACTIVE | SOIC | D | 8 | 2500 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |
| THS3001CDRG4 | ACTIVE | SOIC | D | 8 | 2500 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |
| THS3001HVCDGN | ACTIVE | MSOP- Power PAD | DGN | 8 | 80 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |
| THS3001HVCDGNG4 | ACTIVE | MSOP- Power PAD | DGN | 8 | 80 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |
| THS3001HVCDGNR | ACTIVE | MSOP- Power PAD | DGN | 8 | 2500 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |
| THS3001HVCDGNRG4 | ACTIVE | MSOP- Power PAD | DGN | 8 | 2500 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |
| THS3001HVIDGN | ACTIVE | MSOP- Power PAD | DGN | 8 | 80 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |
| THS3001HVIDGNG4 | ACTIVE | MSOP- Power PAD | DGN | 8 | 80 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |
| THS3001HVIDGNR | ACTIVE | MSOP- Power PAD | DGN | 8 | 2500 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |
| THS3001HVIDGNRG4 | ACTIVE | MSOP- Power PAD | DGN | 8 | 2500 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |
| THS3001ID | ACTIVE | SOIC | D | 8 | 75 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |
| THS3001IDG4 | ACTIVE | SOIC | D | 8 | 75 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |
| THS3001IDGN | ACTIVE | MSOP- Power PAD | DGN | 8 | 80 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |
| THS3001IDGNG4 | ACTIVE | MSOP- | DGN | 8 | 80 | Green (RoHS & | CU NIPDAU | Level-1-260C-UNLIM |



PACKAGE OPTION ADDENDUM

12-Jan-2006

| Orderable Device | Status ⁽¹⁾ | Package Type | Package Drawing | Pins P | ackage Qty | Eco Plan ⁽²⁾ | Lead/Ball Finish | MSL Peak Temp ⁽³⁾ |
|------------------|-----------------------|-----------------------|--------------------|--------|---------------|----------------------------|------------------|------------------------------|
| | | Power PAD | | | | no Sb/Br) | | |
| THS3001IDGNR | ACTIVE | MSOP- Power PAD | DGN | 8 | 2500 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |
| THS3001IDGNRG4 | ACTIVE | MSOP- Power PAD | DGN | 8 | 2500 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |
| THS3001IDR | ACTIVE | SOIC | D | 8 | 2500 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |
| THS3001IDRG4 | ACTIVE | SOIC | D | 8 | 2500 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |

 $^{(1)}$ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

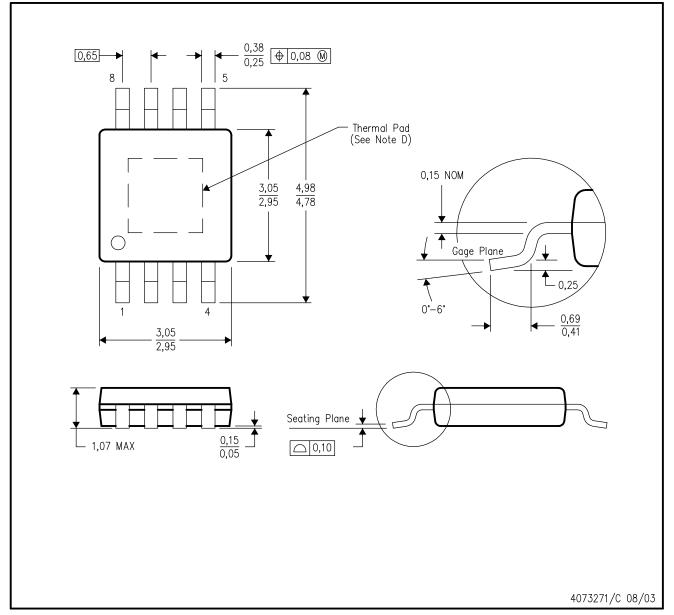
(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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DGN (S-PDSO-G8)

PowerPAD™ PLASTIC SMALL-OUTLINE PACKAGE



NOTES:

- A. All linear dimensions are in millimeters.
 - B. This drawing is subject to change without notice.
 - C. Body dimensions do not include mold flash or protrusion.
 - D. This package is designed to be soldered to a thermal pad on the board. Refer to Technical Brief, PowerPad Thermally Enhanced Package, Texas Instruments Literature No. SLMA002 for information regarding recommended board layout. This document is available at www.ti.com https://www.ti.com.
- E. Falls within JEDEC MO-187

PowerPAD is a trademark of Texas Instruments.



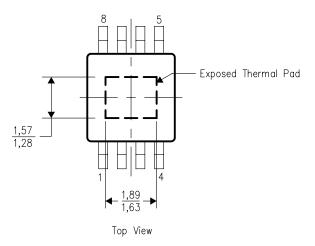


THERMAL INFORMATION

This PowerPAD™ package incorporates an exposed thermal pad that is designed to be attached directly to an external heatsink. When the thermal pad is soldered directly to the printed circuit board (PCB), the PCB can be used as a heatsink. In addition, through the use of thermal vias, the thermal pad can be attached directly to a ground or power plane (whichever is applicable), or alternatively, a special heatsink structure designed into the PCB. This design optimizes the heat transfer from the integrated circuit (IC).

For additional information on the PowerPAD package and how to take advantage of its heat dissipating abilities, refer to Technical Brief, PowerPAD Thermally Enhanced Package, Texas Instruments Literature No. SLMA002 and Application Brief, PowerPAD Made Easy, Texas Instruments Literature No. SLMA004. Both documents are available at www.ti.com.

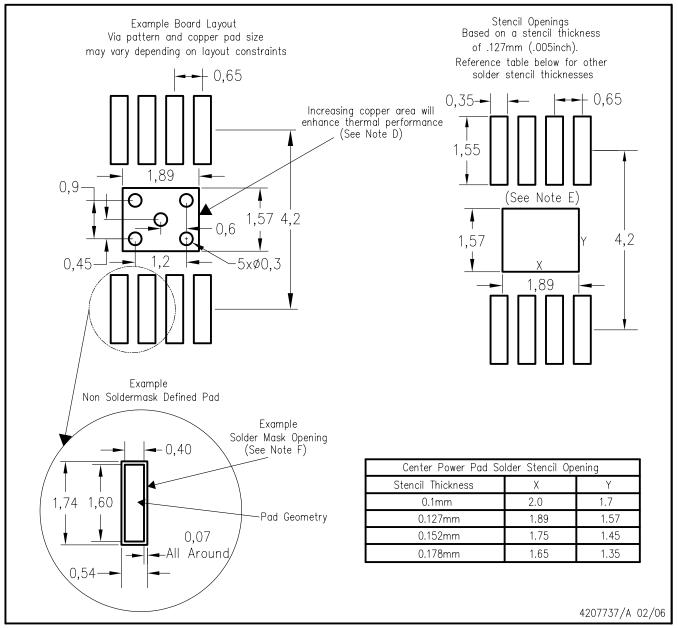
The exposed thermal pad dimensions for this package are shown in the following illustration.



NOTE: All linear dimensions are in millimeters

Exposed Thermal Pad Dimensions

DGN (R-PDSO-G8) PowerPAD™



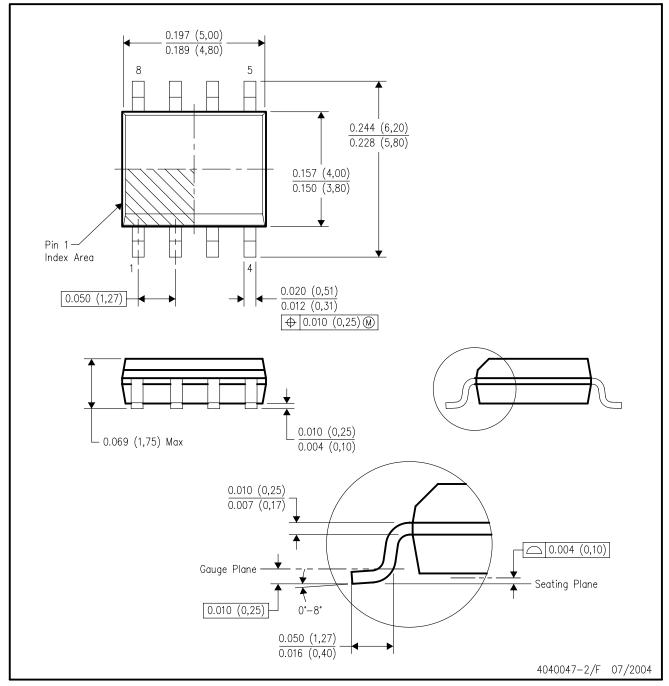
NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Customers should place a note on the circuit board fabrication drawing not to alter the center solder mask defined pad.
- D. This package is designed to be soldered to a thermal pad on the board. Refer to Technical Brief, PowerPad Thermally Enhanced Package, Texas Instruments Literature No. SLMA002, SLMA004, and also the Product Data Sheets for specific thermal information, via requirements, and recommended board layout. These documents are available at www.ti.com http://www.ti.com. Publication IPC-7351 is recommended for alternate designs.
- E. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Example stencil design based on a 50% volumetric metal load solder paste. Refer to IPC-7525 for other stencil recommendations.
- F. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



D (R-PDSO-G8)

PLASTIC SMALL-OUTLINE PACKAGE



NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).
- D. Falls within JEDEC MS-012 variation AA.



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